

**Simplifying and testing the psychometric psychiatric patients' fall risk scale:
an analysis of one-year admissions**

Shen YH, Hsieh CC, Lee MT, Lee WC, Lee BO.
Healthcare (Basel, Switzerland)
2021; 9(9):e11119

ARTICLE IDENTIFIERS

DOI: 10.3390/healthcare9091119
PMID: unavailable
PMCID: not available

JOURNAL IDENTIFIERS

LCCN: 2014247781
pISSN: 2227-9032
eISSN: not available
OCLC ID: not available
CONS ID: not available
US National Library of Medicine ID: not available

This article was identified from a query of the SafetyLit database.